

**Notice of References Cited**Application/Control No.  
09/923,045Applicant(s)/Patent Under  
Reexamination  
RICHARDSON, DAVID E.Examiner  
Tadesse HailuArt Unit  
2173

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,466,973	10-2002	Jaffe, David H.	709/223
	B	US-6,456,306	09-2002	Chin et al.	345/810
	C	US-6,374,293	04-2002	Dev et al.	709/220
	D	US-6,272,150	08-2001	Hrastar et al.	370/486
	E	US-6,040,834	03-2000	Jain et al.	345/853
	F	US-6,061,723	05-2000	Walker et al.	709/224
	G	US-5,990,892	11-1999	Urbain, Fran.cedilla.ois	345/853
	H	US-5,995,916	11-1999	Nixon et al.	702/182
	I	US-5,848,243	12-1998	Kulkarni et al.	709/224
	J	US-5,471,399	11-1995	Tanaka et al.	716/11
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

**BEST AVAILABLE COPY**

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.